

<b>Notice of References Cited</b>	Application/Control No. 10/576,706		Applicant(s)/Patent Under Reexamination LEHMANN ET AL.	
	Examiner ROBERT SELLERS		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,118,567	06-1992	Komiyama et al.	428/345
*	B	US-5,346,933	09-1994	Knell	523/427
*	C	US-5,476,752	12-1995	Noguchi et al.	430/287.1
*	D	US-5,656,336	08-1997	Kamen et al.	427/511
*	E	US-6,485,885	11-2002	Oka et al.	430/270.1
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	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Polysciences, Inc. data sheet for Epon 1001F, 2009, one page.
	V	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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